SCICEX XCTD update Timeline Results What's next? SCICEX SAC, ONR, January 27, 2011 ICEX - 2009

SCICEX XCTD Timeline

- Dedicated Science Cruises 1995-1999
 - ~ 100 analog XCTDs per cruise
 - ~ 85-90% success rate
 - crucial data on changing Arctic Ocean conditions
- Science Accommodation Cruises
 - digital XCTDs
 - higher failure rate
 - noisy
- 2008
 - Sippican: known source of XCTD failures ('timeout circuit')
- 2009
 - SAC Science Plan in preparation
 - XCTD test at ICEX-09
 - Results:
 - T, S, Z quality acceptable
 - complete failure to reach design depth
 - 'success' rate fairly high
- 2010
 - Sippican identifies source of XCTD failures to achieve design depth
 - XCTD open water test by ASL
 - Results: inconclusive

ICEX-09 XCTD Test

Objectives:

- Demonstrate successful deployment of UISSXCTDs using launch procedure that accommodates the 'timeout circuit'
- validate the XCTD design specs for temperature, conductivity, depth

	Z	T (°C)	C (mS/cm)
Range	0 – 1000 m		
Accuracy	2% or 20 m	0.02	0.03
Resolution	17 cm	0.01	0.017

Results:

- 12 of 16 probes launched returned data (75%)
- none of the probes returned data from greater than 600 m
- data revealed none of the salinity spiking typical of the earlier analog data

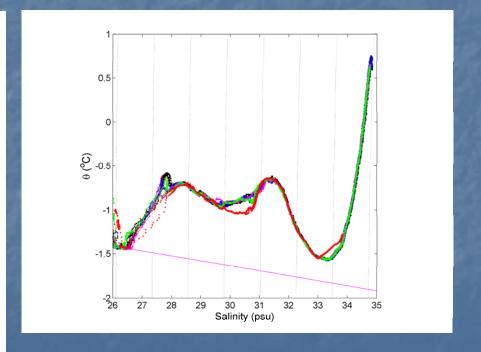
ICEX-09 XCTD test

Temperature and Salinity profiles

XCTD downcasts

Temperature/Salinity relationships

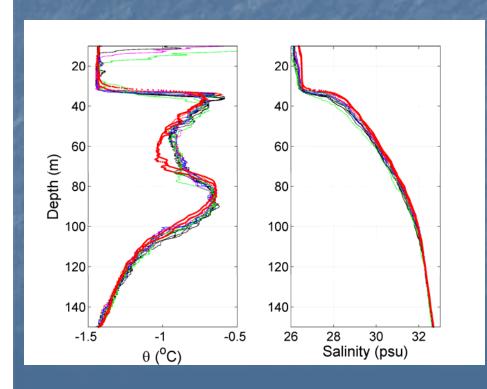
- T,S accuracy
- precision (repeatability)



ICEX-09 XCTD test

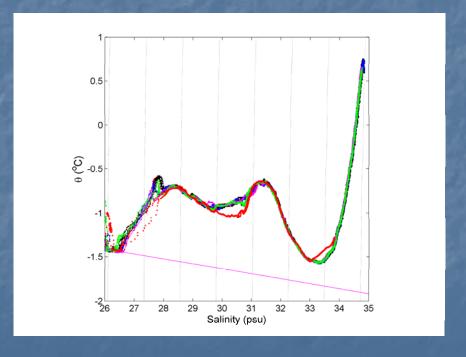
Temperature and Salinity profiles

- XCTD downcasts (ML depths aligned)
- ICEX CTD (red)



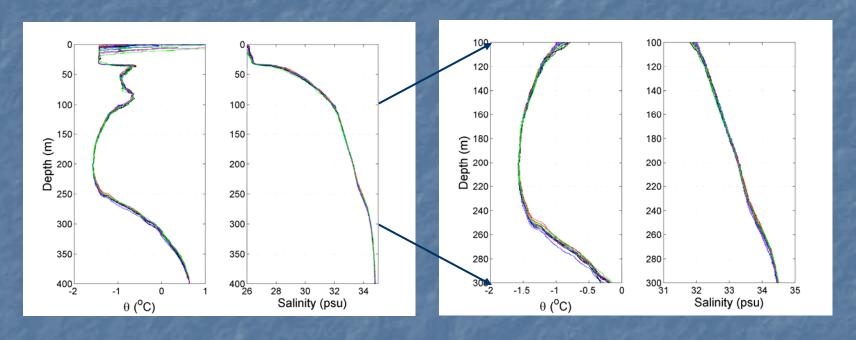
Temperature/Salinity relationships

- T,S accuracy
- precision (repeatability)



ICEX-09 XCTD probe performance

- XCTD downcasts (ML depths aligned)
- precision (repeatability)
- ensemble statistics of profile averages over 205m +/- 2.5m depth



Statistic	Z	JANAS	С	S	Z ml
Average	205	-1.57	2.66	33.31	32.04
RMS	MARKET	0.0040	0.0011	0.0134	3.66
Spread	5	0.0143	0.0041	0.0494	12.71

ICEX-09 XCTD Test

Objectives:

- Demonstrate successful deployment of UISSXCTDs using launch procedure that accommodates the 'timeout circuit'
- validate the XCTD design specs for temperature, conductivity, depth

Conclusions:

- returned data 'success rate' lower than for analog probes used during SCICEX
- failure to achieve specified maximum depth is problem needing resolution
- when successfully returned, quality of the data is good enough for use

December 2010 XCTD Test

Motivation:

 Sippican identified a data acquisition software problem that would affect all XCTDs (ship, air-launched as well as sub-launched) and assured availability of a tested software solution by a late autumn

Test:

- ONR approved funding for a test of 16 XCTD probes
- ASL attempted launch of 3 of these probes Dec 4-5, 2010

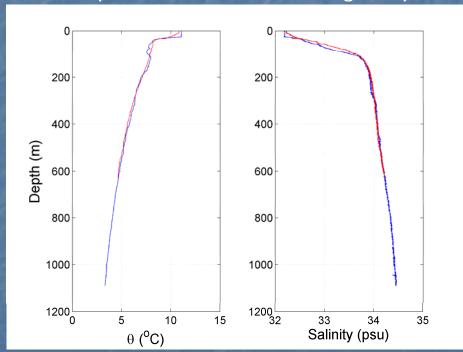
Result:

- 1 probe failed pre-launch test (and was thus not launched)
- 1 probe returned data to 644 m (not to spec'd depth)
- 1 probe returned data to 1088 m
- data (both T & C) was noisier than ICEX-09 data
 - suggestive of a software problem

December 2010 XCTD Test

Results:

- 2 XCTD profiles (cleaned below)
- noisier than ICEX-09
 - isolated points w/ T = 0.00°C, C=1.5 mS/cm
- profiles from surface?
- not all profiles reach max design depth



Conclusions:

- success rate: inconclusive; not enough probes launched
- max depth: wrong version data acquisition software used????

SCICEX SAM XCTD sampling



- Continue XCTD test deployments (13) in ICEX-11
 - Follow Science Plan recommendations
 - Ensure use of correct software
 - Follow-up on XCTD noise and first-depth issues
- ONR proposal for SAM sampling in 2012-2013
 - Assume ICEX-13?

